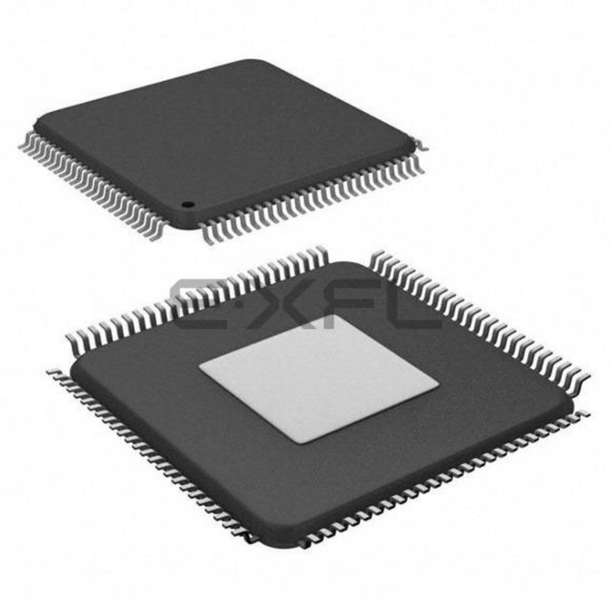
Analog Devices Inc. - ADSP-21489BSWZ-3A Datasheet



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Understanding Embedded - DSP (Digital Signal Processors)

Embedded - DSP (Digital Signal Processors) are specialized microprocessors designed to perform complex mathematical computations on digital signals in real-time. Unlike general-purpose processors, DSPs are optimized for high-speed numeric processing tasks, making them ideal for applications that require efficient and precise manipulation of digital data. These processors are fundamental in converting and processing signals in various forms, including audio, video, and communication signals, ensuring that data is accurately interpreted and utilized in embedded systems.

Applications of Embedded - DSP (Digital Signal Processors)

Details	
Product Status	Active
Type	Floating Point
Interface	EBI/EMI, DAI, I²C, SPI, SPORT, UART/USART
Clock Rate	350MHz
Non-Volatile Memory	External
On-Chip RAM	5Mbit
Voltage - I/O	3.30V
Voltage - Core	1.10V
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP Exposed Pad
Supplier Device Package	100-LQFP-EP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/analog-devices/adsp-21489bswz-3a

GENERAL DESCRIPTION

The ADSP-2148x SHARC® processors are members of the SIMD SHARC family of DSPs that feature Analog Devices' Super Harvard Architecture. The processors are source code compatible with the ADSP-2126x, ADSP-2136x, ADSP-2137x, ADSP-2146x, ADSP-2147x and ADSP-2116x DSPs, as well as with first generation ADSP-2106x SHARC processors in SISD (single-instruction, single-data) mode. The ADSP-2148x processors are 32-bit/40-bit floating point processors optimized for high performance audio applications with large on-chip SRAM, multiple internal buses to eliminate I/O bottlenecks, and an innovative digital applications interface (DAI).

Table 1 shows performance benchmarks for the ADSP-2148x processors. Table 2 shows the features of the individual product offerings.

Table 1. Processor Benchmarks

Benchmark Algorithm	Speed (at 400 MHz)	Speed (at 450 MHz)
1024 Point Complex FFT (Radix 4, with Reversal)	23 μs	20.44 μs
FIR Filter (per Tap)[1]	1.25 ns	1.1 ns
IIR Filter (per Biquad)[1]	5 ns	4.43 ns
Matrix Multiply (Pipelined)		
[3 × 3] × [3 × 1]	11.25 ns	10.0 ns
[4 × 4] × [4 × 1]	20 ns	17.78 ns
Divide (y/×)	7.5 ns	6.67 ns
Inverse Square Root	11.25 ns	10.0 ns

[1] Assumes two files in multichannel SIMD mode

Table 2. ADSP-2148x Family Features

Feature	ADSP-21483	ADSP-21486	ADSP-21487	ADSP-21488	ADSP-21489
Maximum Instruction Rate	400 MHz	400 MHz	450 MHz	400 MHz	450 MHz
RAM	3 Mbits	5 Mbits		2/3 Mbits[1]	5 Mbits
ROM	4 Mbits			No	
Audio Decoders in ROM[2]	Yes			No	
Pulse-Width Modulation	4 Units (3 Units on 100-Lead Packages)				
DTCP Hardware Accelerator	Contact Analog Devices				
External Port Interface (SDRAM, AMI)[3]	Yes (16-bit)	AMI Only	Yes (16-bit)		
Serial Ports	8				
Direct DMA from SPORTs to External Port (External Memory)	Yes				
FIR, IIR, FFT Accelerator	Yes				
Watchdog Timer	Yes (176-Lead Package Only)				
MediaLB Interface	Automotive Models Only				
IDP/PDAP	Yes				
UART	1				
DAI (SRU)/DPI (SRU2)	Yes				
S/PDIF Transceiver	Yes				
SPI	Yes				
TWI	1				
SRC Performance[4]	–128 dB				
Thermal Diode	Yes				
VISA Support	Yes				
Package[3]	176-Lead LQFP EPAD 100-Lead LQFP EPAD		176-Lead LQFP EPAD	176-Lead LQFP EPAD 100-Lead LQFP EPAD[5]	

[1] See Ordering Guide on Page 66.

[2] ROM is factory programmed with latest multichannel audio decoding and post-processing algorithms from Dolby® Labs and DTS®. Decoder/post-processor algorithm combination support varies depending upon the chip version and the system configurations. Please visit www.analog.com for complete information.

[3] The 100-lead packages do not contain an external port. The SDRAM controller pins must be disabled when using this package. For more information, see Pin Function Descriptions on Page 14. The ADSP-21486 processor in the 176-lead package also does not contain a SDRAM controller. For more information, see 176-Lead LQFP_EP Lead Assignment on page 60.

[4] Some models have –140 dB performance. For more information, see Ordering Guide on page 66.

[5] Only available up to 400 MHz. See Ordering Guide on Page 66 for details.

The diagram on Page 1 shows the two clock domains that make up the ADSP-2148x processors. The core clock domain contains the following features:

- Two processing elements (PEx, PEy), each of which comprises an ALU, multiplier, shifter, and data register file
- Data address generators (DAG1, DAG2)
- Program sequencer with instruction cache
- PM and DM buses capable of supporting 2x64-bit data transfers between memory and the core at every core processor cycle
- One periodic interval timer with pinout
- On-chip SRAM (5 Mbit) and mask-programmable ROM (4 Mbit)
- JTAG test access port for emulation and boundary scan. The JTAG provides software debug through user breakpoints which allows flexible exception handling.

The block diagram of the ADSP-2148x on Page 1 also shows the peripheral clock domain (also known as the I/O processor) which contains the following features:

- IOD0 (peripheral DMA) and IOD1 (external port DMA) buses for 32-bit data transfers
- Peripheral and external port buses for core connection
- External port with an AMI and SDRAM controller
- 4 units for PWM control
- 1 memory-to-memory (MTM) unit for internal-to-internal memory transfers
- Digital applications interface that includes four precision clock generators (PCG), an input data port (IDP/PDAP) for serial and parallel interconnects, an S/PDIF receiver/transmitter, four asynchronous sample rate converters, eight serial ports, and a flexible signal routing unit (DAI SRU).
- Digital peripheral interface that includes two timers, a 2-wire interface (TWI), one UART, two serial peripheral interfaces (SPI), 2 precision clock generators (PCG), pulse width modulation (PWM), and a flexible signal routing unit (DPI SRU2).

As shown in the SHARC core block diagram on Page 5, the processor uses two computational units to deliver a significant performance increase over the previous SHARC processors on a range of DSP algorithms. With its SIMD computational hardware, the processors can perform 2.7 GFLOPS running at 450 MHz.

FAMILY CORE ARCHITECTURE

The ADSP-2148x is code compatible at the assembly level with the ADSP-2147x, ADSP-2146x, ADSP-2137x, ADSP-2136x, ADSP-2126x, ADSP-21160, and ADSP-21161, and with the first generation ADSP-2106x SHARC processors. The ADSP-2148x shares architectural features with the ADSP-2126x, ADSP-2136x, ADSP-2137x, ADSP-2146x and ADSP-2116x SIMD SHARC processors, as shown in Figure 2 and detailed in the following sections.

SIMD Computational Engine

The ADSP-2148x contains two computational processing elements that operate as a single-instruction, multiple-data (SIMD) engine. The processing elements are referred to as PEX and PEY and each contains an ALU, multiplier, shifter, and register file. PEx is always active, and PEy may be enabled by setting the PEYEN mode bit in the MODE1 register. SIMD mode allows the processor to execute the same instruction in both processing elements, but each processing element operates on different data. This architecture is efficient at executing math intensive DSP algorithms.

SIMD mode also affects the way data is transferred between memory and the processing elements because twice the data bandwidth is required to sustain computational operation in the processing elements. Therefore, entering SIMD mode also doubles the bandwidth between memory and the processing elements. When using the DAGs to transfer data in SIMD mode, two data values are transferred with each memory or register file access.

Independent, Parallel Computation Units

Within each processing element is a set of computational units. The computational units consist of an arithmetic/logic unit (ALU), multiplier, and shifter. These units perform all operations in a single cycle and are arranged in parallel, maximizing computational throughput. Single multifunction instructions execute parallel ALU and multiplier operations. In SIMD mode, the parallel ALU and multiplier operations occur in both processing elements. These computation units support IEEE 32-bit single-precision floating-point, 40-bit extended precision floating-point, and 32-bit fixed-point data formats.

Timer

The processor contains a core timer that can generate periodic software interrupts. The core timer can be configured to use FLAG3 as a timer expired signal.

Data Register File

Each processing element contains a general-purpose data register file. The register files transfer data between the computation units and the data buses, and store intermediate results. These 10-port, 32-register (16 primary, 16 secondary) register files, combined with the processor's enhanced Harvard architecture, allow unconstrained data flow between computation units and internal memory. The registers in PEX are referred to as R0–R15 and in PEY as S0–S15.

Context Switch

Many of the processor's registers have secondary registers that can be activated during interrupt servicing for a fast context switch. The data registers in the register file, the DAG registers, and the multiplier result registers all have secondary registers. The primary registers are active at reset, while the secondary registers are activated by control bits in a mode control register.

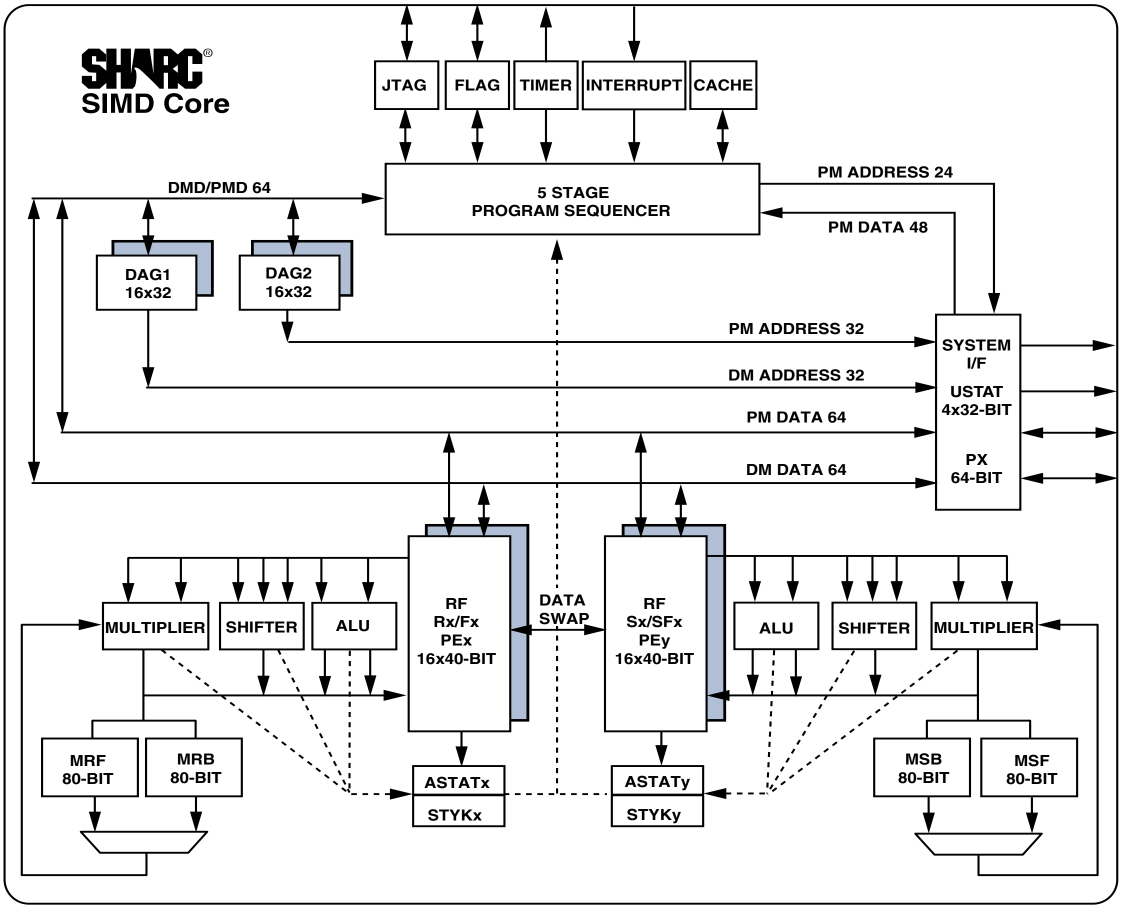

Figure 2. SHARC Core Block Diagram

Universal Registers

These registers can be used for general-purpose tasks. The USTAT (4) registers allow easy bit manipulations (Set, Clear, Toggle, Test, XOR) for all peripheral registers (control/status).

The data bus exchange register (PX) permits data to be passed between the 64-bit PM data bus and the 64-bit DM data bus, or between the 40-bit register file and the PM/DM data bus. These registers contain hardware to handle the data width difference.

Single-Cycle Fetch of Instruction and Four Operands

The ADSP-2148x features an enhanced Harvard architecture in which the data memory (DM) bus transfers data and the program memory (PM) bus transfers both instructions and data. With the its separate program and data memory buses and on-chip instruction cache, the processor can simultaneously fetch four operands (two over each data bus) and one instruction (from the cache), all in a single cycle.

Instruction Cache

The processor includes an on-chip instruction cache that enables three-bus operation for fetching an instruction and four data values. The cache is selective—only the instructions whose fetches conflict with PM bus data accesses are cached. This cache allows full speed execution of core, looped operations such as digital filter multiply-accumulates, and FFT butterfly processing.

Data Address Generators With Zero-Overhead Hardware Circular Buffer Support

The two data address generators (DAGs) are used for indirect addressing and implementing circular data buffers in hardware. Circular buffers allow efficient programming of delay lines and other data structures required in digital signal processing, and are commonly used in digital filters and Fourier transforms. The two DAGs contain sufficient registers to allow the creation of up to 32 circular buffers (16 primary register sets, 16 secondary). The DAGs automatically handle address pointer wraparound, reduce overhead, increase performance, and simplify implementation. Circular buffers can start and end at any memory location.

Flexible Instruction Set

The 48-bit instruction word accommodates a variety of parallel operations, for concise programming. For example, the processor can conditionally execute a multiply, an add, and a

Delay Line DMA

The processor provides delay line DMA functionality. This allows processor reads and writes to external delay line buffers (and hence to external memory) with limited core interaction.

Scatter/Gather DMA

The processor provides scatter/gather DMA functionality. This allows processor DMA reads/writes to/from non contiguous memory blocks.

FFT Accelerator

The FFT accelerator implements a radix-2 complex/real input, complex output FFT with no core intervention. The FFT accelerator runs at the peripheral clock frequency.

FIR Accelerator

The FIR (finite impulse response) accelerator consists of a 1024 word coefficient memory, a 1024 word deep delay line for the data, and four MAC units. A controller manages the accelerator. The FIR accelerator runs at the peripheral clock frequency.

IIR Accelerator

The IIR (infinite impulse response) accelerator consists of a 1440 word coefficient memory for storage of biquad coefficients, a data memory for storing the intermediate data, and one MAC unit. A controller manages the accelerator. The IIR accelerator runs at the peripheral clock frequency.

Watchdog Timer

The watchdog timer is used to supervise the stability of the system software. When used in this way, software reloads the watchdog timer in a regular manner so that the downward counting timer never expires. An expiring timer then indicates that system software might be out of control.

The 32-bit watchdog timer that can be used to implement a software watchdog function. A software watchdog can improve system reliability by forcing the processor to a known state through generation of a system reset, if the timer expires before being reloaded by software. Software initializes the count value of the timer, and then enables the timer. The watchdog timer resets both the core and the internal peripherals. Note that this feature is available on the 176-lead package only.

SYSTEM DESIGN

The following sections provide an introduction to system design options and power supply issues.

Program Booting

The internal memory of the ADSP-2148x boots at system power-up from an 8-bit EPROM via the external port, an SPI master, or an SPI slave. Booting is determined by the boot configuration (BOOT_CFG2–0) pins in Table 9 for the 176-lead package and Table 10 for the 100-lead package.

Table 9. Boot Mode Selection, 176-Lead Package

BOOT_CFG2–0	Booting Mode
000	SPI Slave Boot
001	SPI Master Boot
010	AMI User Boot (for 8-bit Flash Boot)
011	No boot (processor executes from internal ROM after reset)
1xx	Reserved

Table 10. Boot Mode Selection, 100-Lead Package

BOOT_CFG1–0	Booting Mode
00	SPI Slave Boot
01	SPI Master Boot
10	Reserved
11	No boot (processor executes from internal ROM after reset)

The “Running Reset” feature allows a user to perform a reset of the processor core and peripherals, but without resetting the PLL and SDRAM controller, or performing a boot. The functionality of the $\overline{\text{RESETOUT}}/\overline{\text{RUNRSTIN}}$ pin has now been extended to also act as the input for initiating a Running Reset. For more information, see the hardware reference.

Power Supplies

The processors have separate power supply connections for the internal (V_{DD_INT}) and external (V_{DD_EXT}) power supplies. The internal supply must meet the V_{DD_INT} specifications. The external supply must meet the V_{DD_EXT} specification. All external supply pins must be connected to the same power supply.

To reduce noise coupling, the PCB should use a parallel pair of power and ground planes for V_{DD_INT} and GND.

Static Voltage Scaling (SVS)

Some models of the ADSP-2148x feature Static Voltage Scaling (SVS) on the V_{DD_INT} power supply. (See the Ordering Guide on Page 66 for model details.) This voltage specification technique can provide significant performance benefits including 450 MHz core frequency operation without a significant increase in power.

SVS optimizes the required V_{DD_INT} voltage for each individual device to enable enhanced operating frequency up to 450 MHz. The optimized SVS voltage results in a reduction of maximum I_{DD_INT} which enables 450 MHz operation at the same or lower maximum power than 400 MHz operation at a fixed voltage supply. Implementation of SVS requires a specific voltage regulator circuit design and initialization code.

Refer to the Engineer-to-Engineer Note Static Voltage Scaling for ADSP-2148x SHARC Processors (EE-357) for further information. The EE-Note details the requirements and process to implement a SVS power supply system to enable operation up to 450 MHz. This applies only to specific products within the ADSP-2148x family which are capable of supporting 450 MHz operation.

Table 11. Pin Descriptions (Continued)

Name	Type	State During/ After Reset	Description
MLBCLK[1]	I		**Media Local Bus Clock.** This clock is generated by the MLB controller that is synchronized to the MOST network and provides the timing for the entire MLB interface at 49.152 MHz at FS=48 kHz. When the MLB controller is not used, this pin should be grounded.
MLBDAT[1]	I/O/T in 3 pin mode. I in 5 pin mode.	High-Z	**Media Local Bus Data.** The MLBDAT line is driven by the transmitting MLB device and is received by all other MLB devices including the MLB controller. The MLBDAT line carries the actual data. In 5-pin MLB mode, this pin is an input only. When the MLB controller is not used, this pin should be grounded.
MLBSIG[1]	I/O/T in 3 pin mode. I in 5 pin mode	High-Z	**Media Local Bus Signal.** This is a multiplexed signal which carries the Channel/Address generated by the MLB Controller, as well as the Command and RxStatus bytes from MLB devices. In 5-pin mode, this pin is input only. When the MLB controller is not used, this pin should be grounded.
MLBDO[1]	O/T	High-Z	**Media Local Bus Data Output (in 5 pin mode).** This pin is used only in 5-pin MLB mode. This serves as the output data pin in 5-pin mode. When the MLB controller is not used, this pin should be connected to ground.
MLBSO[1]	O/T	High-Z	**Media Local Bus Signal Output (in 5 pin mode).** This pin is used only in 5-pin MLB mode. This serves as the output signal pin in 5-pin mode. When the MLB controller is not used, this pin should be connected to ground.
TDI	I (ipu)		**Test Data Input (JTAG).** Provides serial data for the boundary scan logic.
TDO	O/T	High-Z	**Test Data Output (JTAG).** Serial scan output of the boundary scan path.
TMS	I (ipu)		**Test Mode Select (JTAG).** Used to control the test state machine.
TCK	I		**Test Clock (JTAG).** Provides a clock for JTAG boundary scan. TCK must be asserted (pulsed low) after power-up or held low for proper operation of the device.
$\overline{\text{TRST}}$	I (ipu)		**Test Reset (JTAG).** Resets the test state machine. $\overline{\text{TRST}}$ must be asserted (pulsed low) after power-up or held low for proper operation of the processor.
$\overline{\text{EMU}}$	O (O/D, ipu)	High-Z	**Emulation Status.** Must be connected to the ADSP-2148x Analog Devices DSP Tools product line of JTAG emulators target board connector only.

The following symbols appear in the Type column of this table: **A** = asynchronous, **I** = input, **O** = output, **S** = synchronous, **A/D** = active drive, **O/D** = open drain, and **T** = three-state, **ipd** = internal pull-down resistor, **ipu** = internal pull-up resistor.

The internal pull-up (ipu) and internal pull-down (ipd) resistors are designed to hold the internal path from the pins at the expected logic levels. To pull-up or pull-down the external pads to the expected logic levels, use external resistors. Internal pull-up/pull-down resistors cannot be enabled/disabled and the value of these resistors cannot be programmed. The range of an ipu resistor can be between 26 kΩ–63 kΩ. The range of an ipd resistor can be between 31 kΩ–85kΩ. The three-state voltage of ipu pads will not reach to the full V_{DD_EXT} level; at typical conditions the voltage is in the range of 2.3 V to 2.7 V.

In this table, all pins are LVTTL compliant with the exception of the thermal diode pins.

Table 11. Pin Descriptions (Continued)

Name	Type	State During/ After Reset	Description
CLK_CFG$_{1–0}$	I		**Core to CLKIN Ratio Control.** These pins set the start up clock frequency. Note that the operating frequency can be changed by programming the PLL multiplier and divider in the PMCTL register at any time after the core comes out of reset. The allowed values are: 00 = 8:1 01 = 32:1 10 = 16:1 11 = reserved
CLKIN	I		**Local Clock In.** Used in conjunction with XTAL. CLKIN is the clock input. It configures the processors to use either its internal clock generator or an external clock source. Connecting the necessary components to CLKIN and XTAL enables the internal clock generator. Connecting the external clock to CLKIN while leaving XTAL unconnected configures the processors to use the external clock source such as an external clock oscillator. CLKIN may not be halted, changed, or operated below the specified frequency.
XTAL	O		**Crystal Oscillator Terminal.** Used in conjunction with CLKIN to drive an external crystal.
$\overline{\text{RESET}}$	I		**Processor Reset.** Resets the processor to a known state. Upon deassertion, there is a 4096 CLKIN cycle latency for the PLL to lock. After this time, the core begins program execution from the hardware reset vector address. The $\overline{\text{RESET}}$ input must be asserted (low) at power-up.
$\overline{\text{RESETOUT}}$/ $\overline{\text{RUNRSTIN}}$	I/O (ipu)		**Reset Out/Running Reset In.** The default setting on this pin is reset out. This pin also has a second function as RUNRSTIN which is enabled by setting bit 0 of the RUNRSTCTL register. For more information, see the hardware reference.
BOOT_CFG$_{2–0}$	I		**Boot Configuration Select.** These pins select the boot mode for the processor (see Table 9). The BOOT_CFG pins must be valid before $\overline{\text{RESET}}$ (hardware and software) is asserted.

The following symbols appear in the Type column of this table: **A** = asynchronous, **I** = input, **O** = output, **S** = synchronous, **A/D** = active drive, **O/D** = open drain, and **T** = three-state, **ipd** = internal pull-down resistor, **ipu** = internal pull-up resistor.

The internal pull-up (ipu) and internal pull-down (ipd) resistors are designed to hold the internal path from the pins at the expected logic levels. To pull-up or pull-down the external pads to the expected logic levels, use external resistors. Internal pull-up/pull-down resistors cannot be enabled/disabled and the value of these resistors cannot be programmed. The range of an ipu resistor can be between 26 kΩ–63 kΩ. The range of an ipd resistor can be between 31 kΩ–85kΩ. The three-state voltage of ipu pads will not reach to the full V_{DD_EXT} level; at typical conditions the voltage is in the range of 2.3 V to 2.7 V.

In this table, all pins are LVTTL compliant with the exception of the thermal diode pins.

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[1] The MLB pins are only available on the automotive models.

Table 12. Pin List, Power and Ground

Name	Type	Description
V_{DD_INT}	P	**Internal Power Supply**
V_{DD_EXT}	P	**I/O Power Supply**
GND[1]	G	**Ground**
V_{DD_THD}	P	**Thermal Diode Power Supply**. When not used, this pin can be left floating.

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[1] The exposed pad is required to be electrically and thermally connected to GND. Implement this by soldering the exposed pad to a GND PCB land that is the same size as the exposed pad. The GND PCB land should be robustly connected to the GND plane in the PCB for best electrical and thermal performance. No separate GND pins are provided in the package.

TIMING SPECIFICATIONS

Use the exact timing information given. Do not attempt to derive parameters from the addition or subtraction of others. While addition or subtraction would yield meaningful results for an individual device, the values given in this data sheet reflect statistical variations and worst cases. Consequently, it is not meaningful to add parameters to derive longer times. See Figure 43 on Page 55 for voltage reference levels.

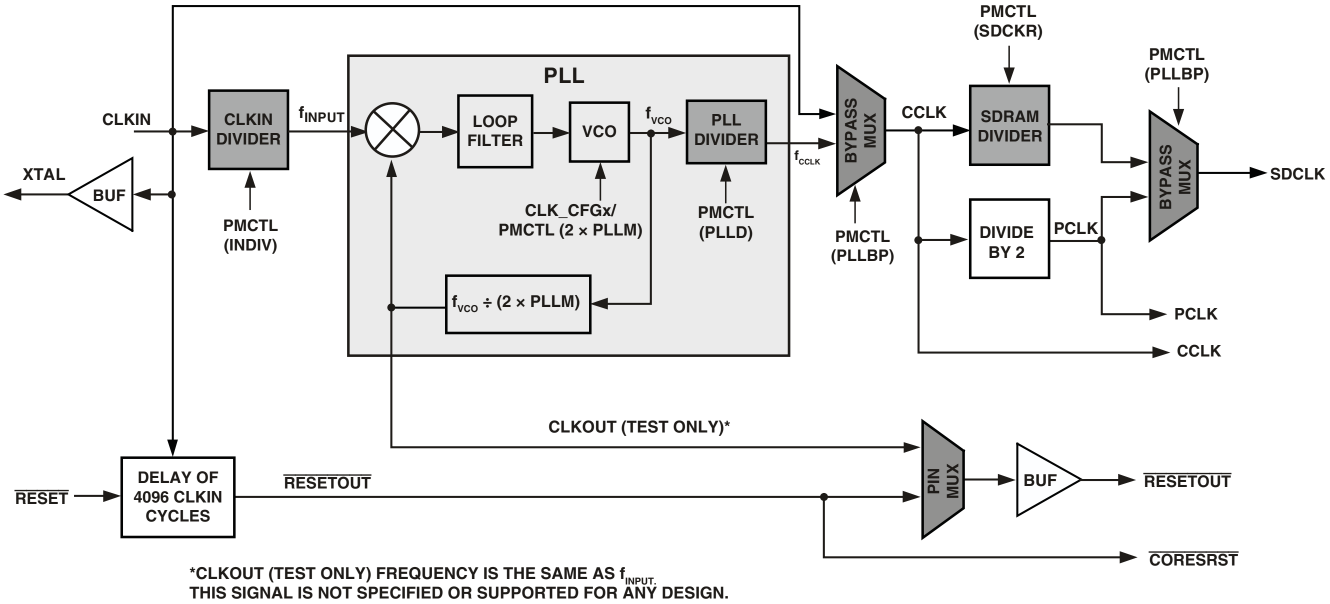
Switching characteristics specify how the processor changes its signals. Circuitry external to the processor must be designed for compatibility with these signal characteristics. Switching characteristics describe what the processor will do in a given circumstance. Use switching characteristics to ensure that any timing requirement of a device connected to the processor (such as memory) is satisfied.

Timing requirements apply to signals that are controlled by circuitry external to the processor, such as the data input for a read operation. Timing requirements guarantee that the processor operates correctly with other devices.

Core Clock Requirements

The processor's internal clock (a multiple of CLKIN) provides the clock signal for timing internal memory, the processor core, and the serial ports. During reset, program the ratio between the processor's internal clock frequency and external (CLKIN) clock frequency with the CLK_CFG1–0 pins.

The processor's internal clock switches at higher frequencies than the system input clock (CLKIN). To generate the internal clock, the processor uses an internal phase-locked loop (PLL, see Figure 4). This PLL-based clocking minimizes the skew between the system clock (CLKIN) signal and the processor's internal clock.



*CLKOUT (TEST ONLY) FREQUENCY IS THE SAME AS f_{INPUT}.
THIS SIGNAL IS NOT SPECIFIED OR SUPPORTED FOR ANY DESIGN.

Figure 4. Core Clock and System Clock Relationship to CLKIN

Voltage Controlled Oscillator (VCO)

In application designs, the PLL multiplier value should be selected in such a way that the VCO frequency never exceeds f_{VCO} specified in Table 20.

- The product of CLKIN and PLLM must never exceed 1/2 of f_{VCO} (max) in Table 20 if the input divider is not enabled (INDIV = 0).
- The product of CLKIN and PLLM must never exceed f_{VCO} (max) in Table 20 if the input divider is enabled (INDIV = 1).

The VCO frequency is calculated as follows:

$$f_{VCO} = 2 \times PLLM \times f_{INPUT}$$
$$f_{CCLK} = (2 \times PLLM \times f_{INPUT}) \div PLLD$$

where:

f_{VCO} = VCO output

$PLLM$ = Multiplier value programmed in the PMCTL register. During reset, the PLLM value is derived from the ratio selected using the CLK_CFG pins in hardware.

$PLLD$ = 2, 4, 8, or 16 based on the divider value programmed on the PMCTL register. During reset this value is 2.

f_{INPUT} = is the input frequency to the PLL.

f_{INPUT} = CLKIN when the input divider is disabled or

f_{INPUT} = CLKIN ÷ 2 when the input divider is enabled

AMI Read

Use these specifications for asynchronous interfacing to memories. Note that timing for AMI_ACK, ADDR, DATA, $\overline{\text{AMI\_RD}}$, $\overline{\text{AMI\_WR}}$, and strobe timing parameters only apply to asynchronous access mode.

Table 32. AMI Read

Parameter		Min	Max	Unit
Timing Requirements				
t_{DAD}[1, 2, 3]	Address Selects Delay to Data Valid		$W + t_{SDCLK} - 5.4$	ns
t_{DRLD}[1, 3]	$\overline{\text{AMI\_RD}}$ Low to Data Valid		$W - 3.2$	ns
t_{SDS}	Data Setup to $\overline{\text{AMI\_RD}}$ High	2.5		ns
t_{HDRH}[4, 5]	Data Hold from $\overline{\text{AMI\_RD}}$ High	0		ns
t_{DAAK}[2, 6]	AMI_ACK Delay from Address, Selects		$t_{SDCLK} - 9.5 + W$	ns
t_{DSAK}[4]	AMI_ACK Delay from $\overline{\text{AMI\_RD}}$ Low		$W - 7$	ns
Switching Characteristics				
t_{DRHA}	Address Selects Hold After $\overline{\text{AMI\_RD}}$ High	$RHC + 0.20$		ns
t_{DARL}[2]	Address Selects to $\overline{\text{AMI\_RD}}$ Low	$t_{SDCLK} - 3.8$		ns
t_{RW}	$\overline{\text{AMI\_RD}}$ Pulse Width	$W - 1.4$		ns
t_{RWR}	$\overline{\text{AMI\_RD}}$ High to $\overline{\text{AMI\_RD}}$ Low	$HI + t_{SDCLK} - 1$		ns

W = (number of wait states specified in AMICTLx register) × t_{SDCLK}.
RHC = (number of Read Hold Cycles specified in AMICTLx register) × t_{SDCLK}
  Where PREDIS = 0
    HI = RHC (if IC=0): Read to Read from same bank
    HI = RHC + t_{SDCLK} (if IC>0): Read to Read from same bank
    HI = RHC + IC: Read to Read from different bank
    HI = RHC + Max (IC, (4 × t_{SDCLK})): Read to Write from same or different bank
  Where PREDIS = 1
    HI = RHC + Max (IC, (4 × t_{SDCLK})): Read to Write from same or different bank
    HI = RHC + (3 × t_{SDCLK}): Read to Read from same bank
    HI = RHC + Max (IC, (3 × t_{SDCLK}): Read to Read from different bank
IC = (number of idle cycles specified in AMICTLx register) × t_{SDCLK}
H = (number of hold cycles specified in AMICTLx register) × tSDCLK

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[1] Data delay/setup: System must meet t_{DAD}, t_{DRLD}, or t_{SDS}.

[2] The falling edge of $\overline{\text{MS}}$x, is referenced.

[3] The maximum limit of timing requirement values for t_{DAD} and t_{DRLD} parameters are applicable for the case where AMI_ACK is always high and when the ACK feature is not used.

[4] Note that timing for AMI_ACK, ADDR, DATA, $\overline{\text{AMI\_RD}}$, $\overline{\text{AMI\_WR}}$, and strobe timing parameters only apply to asynchronous access mode.

[5] Data hold: User must meet t_{HDRH} in asynchronous access mode. See Test Conditions on Page 55 for the calculation of hold times given capacitive and dc loads.

[6] AMI_ACK delay/setup: User must meet t_{DAAK}, or t_{DSAK}, for deassertion of AMI_ACK (low).

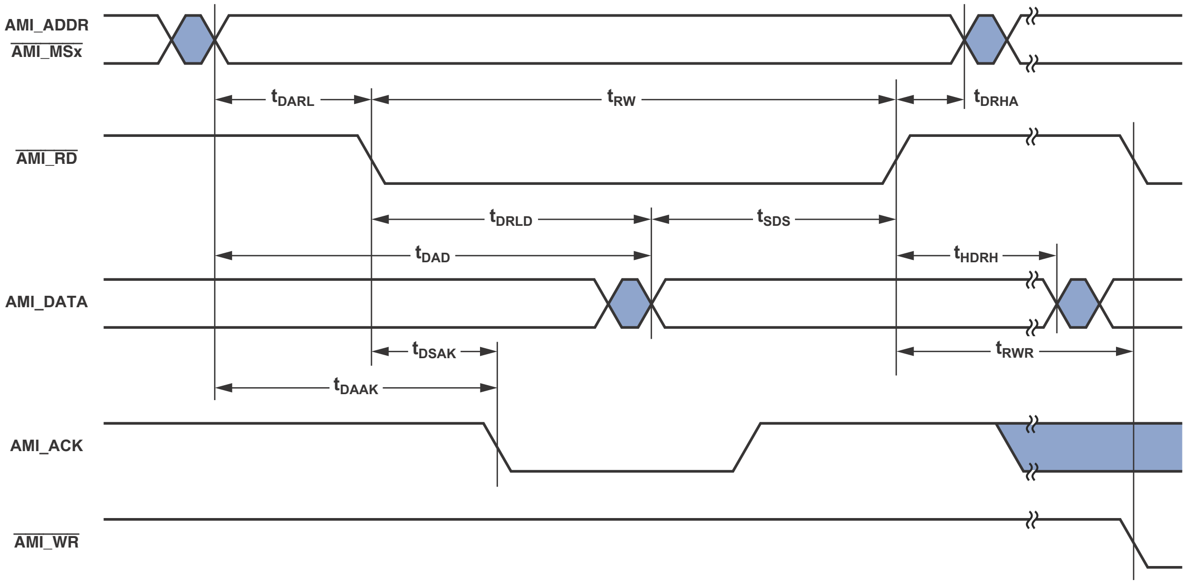

Figure 19. AMI Read

AMI Write

Use these specifications for asynchronous interfacing to memories. Note that timing for AMI_ACK, ADDR, DATA, $\overline{\text{AMI\_RD}}$, $\overline{\text{AMI\_WR}}$, and strobe timing parameters only apply to asynchronous access mode.

Table 33. AMI Write

Parameter		Min	Max	Unit
Timing Requirements				
t_{DAAK}[1, 2]	AMI_ACK Delay from Address, Selects		$t_{SDCLK} - 9.7 + W$	ns
t_{DSAK}[1, 3]	AMI_ACK Delay from $\overline{\text{AMI\_WR}}$ Low		$W - 6$	ns
Switching Characteristics				
t_{DAWH}[2]	Address Selects to $\overline{\text{AMI\_WR}}$ Deasserted	$t_{SDCLK} - 3.1 + W$		ns
t_{DAWL}[2]	Address Selects to $\overline{\text{AMI\_WR}}$ Low	$t_{SDCLK} - 3$		ns
t_{WW}	$\overline{\text{AMI\_WR}}$ Pulse Width	$W - 1.3$		ns
t_{DDWH}	Data Setup Before $\overline{\text{AMI\_WR}}$ High	$t_{SDCLK} - 3.7 + W$		ns
t_{DWHA}	Address Hold After $\overline{\text{AMI\_WR}}$ Deasserted	$H + 0.15$		ns
t_{DWHD}	Data Hold After $\overline{\text{AMI\_WR}}$ Deasserted	H		ns
t_{DATRWH}[4]	Data Disable After $\overline{\text{AMI\_WR}}$ Deasserted	$t_{SDCLK} - 4.3 + H$	$t_{SDCLK} + 4.9 + H$	ns
t_{WWR}[5]	$\overline{\text{AMI\_WR}}$ High to $\overline{\text{AMI\_WR}}$ Low	$t_{SDCLK} - 1.5 + H$		ns
t_{DDWR}	Data Disable Before $\overline{\text{AMI\_RD}}$ Low	$2 \times t_{SDCLK} - 6$		ns
t_{WDE}	Data Enabled to $\overline{\text{AMI\_WR}}$ Low	$t_{SDCLK} - 3.7$		ns

W = (number of wait states specified in AMICTLx register) × t_{SDCLK}
H = (number of hold cycles specified in AMICTLx register) × t_{SDCLK}

---

[1] AMI_ACK delay/setup: System must meet t_{DAAK}, or t_{DSAK}, for deassertion of AMI_ACK (low).
[2] The falling edge of $\overline{\text{MSx}}$ is referenced.
[3] Note that timing for AMI_ACK, $\overline{\text{AMI\_RD}}$, $\overline{\text{AMI\_WR}}$, and strobe timing parameters only applies to asynchronous access mode.
[4] See Test Conditions on Page 55 for calculation of hold times given capacitive and dc loads.
[5] For Write to Write: $t_{SDCLK} + H$, for both same bank and different bank. For Write to Read: $3 \times t_{SDCLK} + H$, for the same bank and different banks.

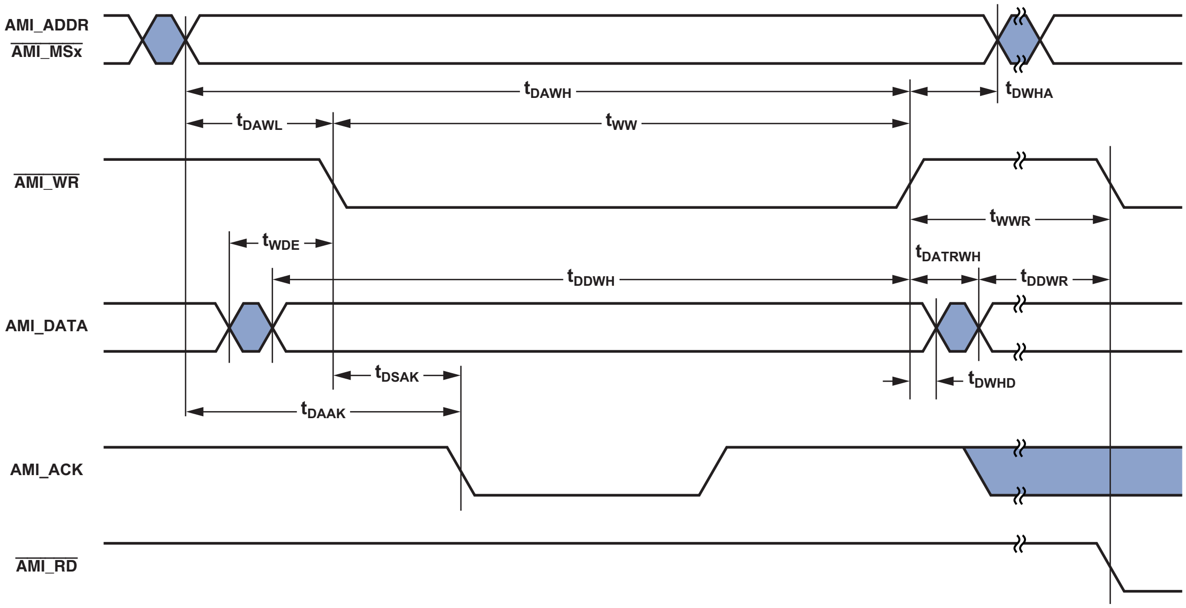

Figure 20. AMI Write

Sample Rate Converter—Serial Output Port

For the serial output port, the frame sync is an input, and it should meet setup and hold times with regard to SCLK on the output port. The serial data output has a hold time and delay specification with regard to serial clock. Note that serial clock rising edge is the sampling edge, and the falling edge is the drive edge.

Table 42. ASRC, Serial Output Port

Parameter		Min	Max	Unit
Timing Requirements				
t_{SRCSFS}[1]	Frame Sync Setup Before Serial Clock Rising Edge	4		ns
t_{SRCHFS}[1]	Frame Sync Hold After Serial Clock Rising Edge	5.5		ns
$t_{SRCCLKW}$	Clock Width	$(t_{PCLK} \times 4) \div 2 - 1$		ns
t_{SRCCLK}	Clock Period	$t_{PCLK} \times 4$		ns
Switching Characteristics				
t_{SRCTDD}[1]	Transmit Data Delay After Serial Clock Falling Edge		9.9	ns
t_{SRCTDH}[1]	Transmit Data Hold After Serial Clock Falling Edge	1		ns

[1] The serial clock, data, and frame sync signals can come from any of the DAI pins. The serial clock and frame sync signals can also come via PCG or SPORTs. PCG's input can be either CLKIN or any of the DAI pins.

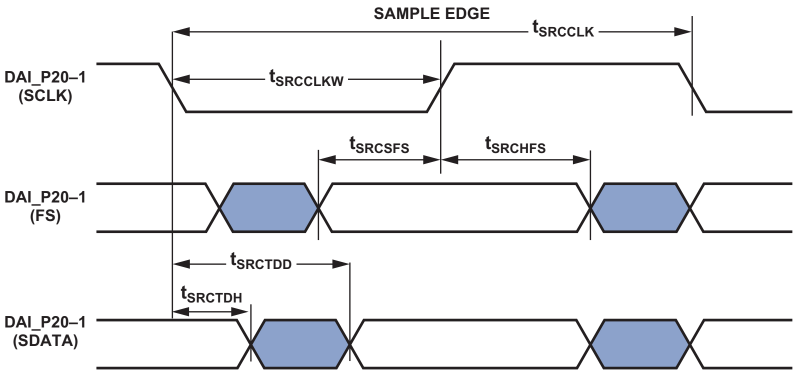

Figure 28. ASRC Serial Output Port Timing

Pulse-Width Modulation Generators (PWM)

The following timing specifications apply when the ADDR23–8/DPI_14–1 pins are configured as PWM.

Table 43. Pulse-Width Modulation (PWM) Timing

Parameter		Min	Max	Unit
Switching Characteristics				
t_{PWMW}	PWM Output Pulse Width	$t_{PCLK} - 2$	$(2^{16} - 2) \times t_{PCLK}$	ns
t_{PWMP}	PWM Output Period	$2 \times t_{PCLK} - 1.5$	$(2^{16} - 1) \times t_{PCLK}$	ns

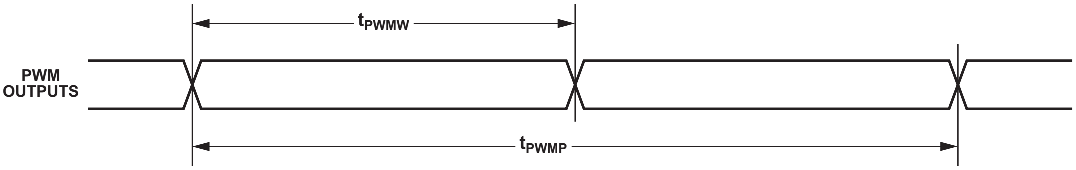

Figure 29. PWM Timing

S/PDIF Transmitter

Serial data input to the S/PDIF transmitter can be formatted as left-justified, I^2S, or right-justified with word widths of 16, 18, 20, or 24 bits. The following sections provide timing for the transmitter.

S/PDIF Transmitter-Serial Input Waveforms

Figure 30 shows the right-justified mode. Frame sync is high for the left channel and low for the right channel. Data is valid on the rising edge of serial clock. The MSB is delayed the minimum in 24-bit output mode or the maximum in 16-bit output mode from a frame sync transition, so that when there are 64 serial clock periods per frame sync period, the LSB of the data is right-justified to the next frame sync transition.

Table 44. S/PDIF Transmitter Right-Justified Mode

Parameter		Nominal	Unit
Timing Requirement			
t_{RJD}	Frame Sync to MSB Delay in Right-Justified Mode		
	16-Bit Word Mode	16	SCLK
	18-Bit Word Mode	14	SCLK
	20-Bit Word Mode	12	SCLK
	24-Bit Word Mode	8	SCLK

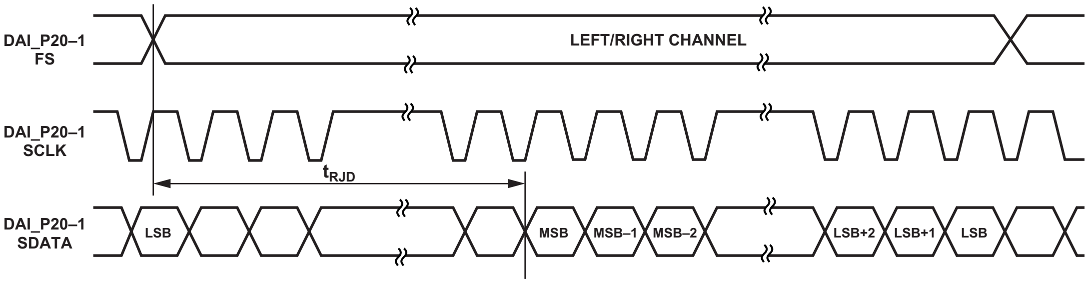

Figure 30. Right-Justified Mode

S/PDIF Transmitter Input Data Timing

The timing requirements for the S/PDIF transmitter are given in Table 47. Input signals are routed to the DAI_P20–1 pins using the SRU. Therefore, the timing specifications provided below are valid at the DAI_P20–1 pins.

Table 47. S/PDIF Transmitter Input Data Timing

Parameter		Min	Max	Unit
Timing Requirements				
t_{SISFS}[1]	Frame Sync Setup Before Serial Clock Rising Edge	3		ns
t_{SIHFS}[1]	Frame Sync Hold After Serial Clock Rising Edge	3		ns
t_{SISD}[1]	Data Setup Before Serial Clock Rising Edge	3		ns
t_{SIHD}[1]	Data Hold After Serial Clock Rising Edge	3		ns
$t_{SITXCLKW}$	Transmit Clock Width	9		ns
$t_{SITXCLK}$	Transmit Clock Period	20		ns
$t_{SISCLKW}$	Clock Width	36		ns
t_{SISCLK}	Clock Period	80		ns

[1] The serial clock, data, and frame sync signals can come from any of the DAI pins. The serial clock and frame sync signals can also come via PCG or SPORTs. PCG's input can be either CLKIN or any of the DAI pins.

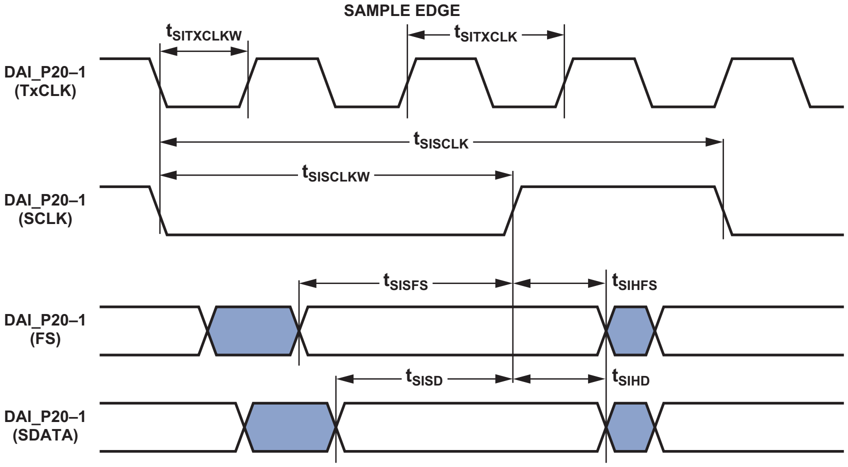

Figure 33. S/PDIF Transmitter Input Timing

Oversampling Clock (TxCLK) Switching Characteristics

The S/PDIF transmitter requires an oversampling clock input. This high frequency clock (TxCLK) input is divided down to generate the internal biphase clock.

Table 48. Oversampling Clock (TxCLK) Switching Characteristics

Parameter	Max	Unit
Frequency for TxCLK = 384 × Frame Sync	Oversampling Ratio × Frame Sync <= $1/t_{SITXCLK}$	MHz
Frequency for TxCLK = 256 × Frame Sync	49.2	MHz
Frame Rate (FS)	192.0	kHz

S/PDIF Receiver

The following section describes timing as it relates to the S/PDIF receiver.

Internal Digital PLL Mode

In the internal digital phase-locked loop mode the internal PLL (digital PLL) generates the 512 × FS clock.

Table 49. S/PDIF Receiver Internal Digital PLL Mode Timing

Parameter		Min	Max	Unit
Switching Characteristics				
t_{DFSI}	Frame Sync Delay After Serial Clock		5	ns
t_{HOFSI}	Frame Sync Hold After Serial Clock	−2		ns
t_{DDTI}	Transmit Data Delay After Serial Clock		5	ns
t_{HDTI}	Transmit Data Hold After Serial Clock	−2		ns
t_{SCLKIW}[1]	Transmit Serial Clock Width	$8 \times t_{PCLK} - 2$		ns

[1] SCLK frequency is 64 × FS where FS = the frequency of frame sync.

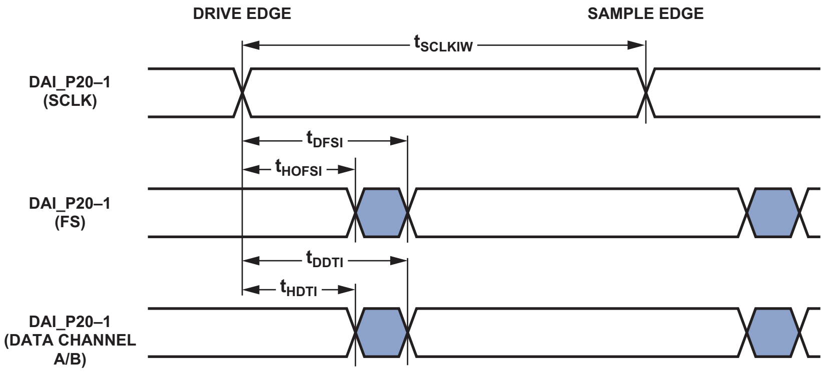

Figure 34. S/PDIF Receiver Internal Digital PLL Mode Timing

Media Local Bus

All the numbers given are applicable for all speed modes (1024 FS, 512 FS and 256 FS for 3-pin; 512 FS and 256 FS for 5-pin), unless otherwise specified. Please refer to the MediaLB specification document revision 3.0 for more details.

Table 52. MLB Interface, 3-Pin Specifications

Parameter		Min	Typ	Max	Unit
3-Pin Characteristics					
t_{MLBCLK}	MLB Clock Period				
	1024 FS		20.3		ns
	512 FS		40		ns
	256 FS		81		ns
t_{MCKL}	MLBCLK Low Time				
	1024 FS	6.1			ns
	512 FS	14			ns
	256 FS	30			ns
t_{MCKH}	MLBCLK High Time				
	1024 FS	9.3			ns
	512 FS	14			ns
	256 FS	30			ns
t_{MCKR}	MLBCLK Rise Time (V_{IL} to V_{IH})				
	1024 FS			1	ns
	512 FS/256 FS			3	ns
t_{MCKF}	MLBCLK Fall Time (V_{IH} to V_{IL})				
	1024 FS			1	ns
	512 FS/256 FS			3	ns
t_{MPWV}[1]	MLBCLK Pulse Width Variation				
	1024 FS			0.7	nspp
	512 FS/256			2.0	nspp
t_{DSMCF}	DAT/SIG Input Setup Time	1			ns
t_{DHMCF}	DAT/SIG Input Hold Time	2			ns
t_{MCFDZ}	DAT/SIG Output Time to Three-state	0		15	ns
t_{MCDRV}	DAT/SIG Output Data Delay From MLBCLK Rising Edge			8	ns
t_{MDZH}[2]	Bus Hold Time				
	1024 FS	2			ns
	512 FS/256	4			ns
C_{MLB}	DAT/SIG Pin Load				
	1024 FS			40	pf
	512 FS/256			60	pf

[1] Pulse width variation is measured at 1.25 V by triggering on one edge of MLBCLK and measuring the spread on the other edge, measured in ns peak-to-peak (pp).

[2] The board must be designed to ensure that the high-impedance bus does not leave the logic state of the final driven bit for this time period. Therefore, coupling must be minimized while meeting the maximum capacitive load listed.

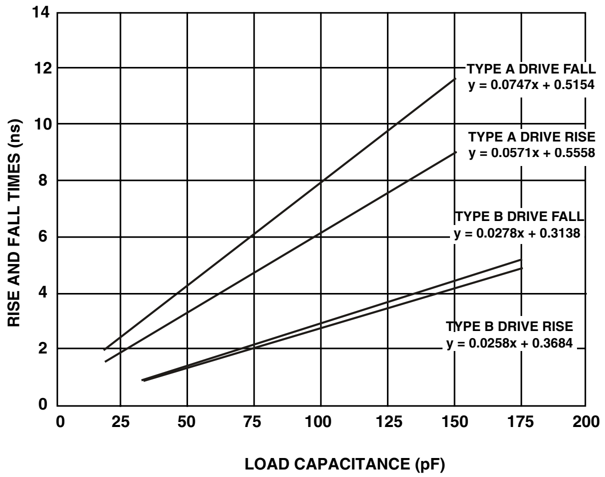

Figure 45. Typical Output Rise/Fall Time (20% to 80%, V_{DD_EXT} = Min)

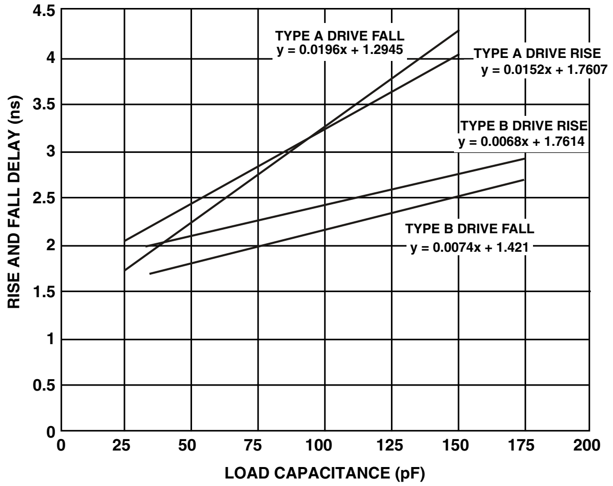

Figure 46. Typical Output Rise/Fall Delay (V_{DD_EXT} = Max)

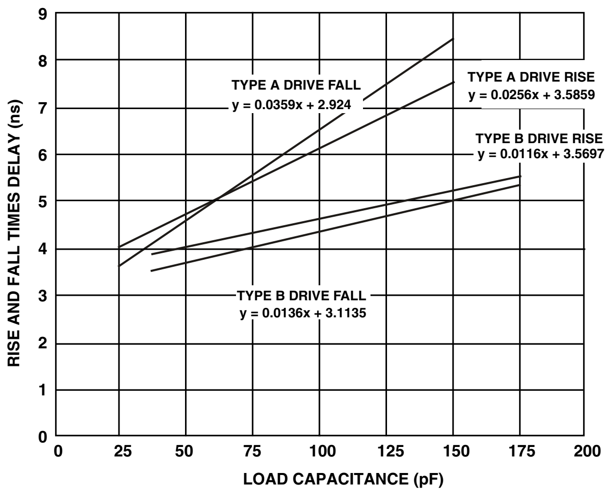

Figure 47. Typical Output Rise/Fall Delay (V_{DD_EXT} = Min)

THERMAL CHARACTERISTICS

The ADSP-2148x processor is rated for performance over the temperature range specified in Operating Conditions on Page 18.

Table 57 airflow measurements comply with JEDEC standards JESD51-2 and JESD51-6, and the junction-to-board measurement complies with JESD51-8. Test board design complies with JEDEC standards JESD51-7 (LQFP_EP). The junction-to-case measurement complies with MIL- STD-883. All measurements use a 2S2P JEDEC test board.

To determine the junction temperature of the device while on the application PCB, use:

$$T_J = T_{CASE} + (\Psi_{JT} \times P_D)$$

where:

T_J = junction temperature °C

T_{CASE} = case temperature (°C) measured at the top center of the package

Ψ_{JT} = junction-to-top (of package) characterization parameter is the Typical value from Table 57.

P_D = power dissipation

Values of θ_{JA} are provided for package comparison and PCB design considerations. θ_{JA} can be used for a first order approximation of T_J by the equation:

$$T_J = T_A + (\theta_{JA} \times P_D)$$

where:

T_A = ambient temperature °C

Values of θ_{JC} are provided for package comparison and PCB design considerations when an external heatsink is required.

176-LEAD LQFP_EP LEAD ASSIGNMENT

Table 60. ADSP-21486 176-Lead LQFP_EP Lead Assignment (Numerical by Lead Number)

Lead Name	Lead No.	Lead Name	Lead No.	Lead Name	Lead No.	Lead Name	Lead No.
NC	1	V_{DD_EXT}	45	DAI_P10	89	V_{DD_INT}	133
$\overline{\text{MS0}}$	2	DPI_P08	46	V_{DD_INT}	90	FLAG0	134
NC	3	DPI_P07	47	V_{DD_EXT}	91	FLAG1	135
V_{DD_INT}	4	V_{DD_INT}	48	DAI_P20	92	FLAG2	136
CLK_CFG1	5	DPI_P09	49	V_{DD_INT}	93	GND	137
ADDR0	6	DPI_P10	50	DAI_P08	94	FLAG3	138
BOOT_CFG0	7	DPI_P11	51	DAI_P14	95	GND	139
V_{DD_EXT}	8	DPI_P12	52	DAI_P04	96	GND	140
ADDR1	9	DPI_P13	53	DAI_P18	97	V_{DD_EXT}	141
ADDR2	10	DPI_P14	54	DAI_P17	98	GND	142
ADDR3	11	DAI_P03	55	DAI_P16	99	V_{DD_INT}	143
ADDR4	12	NC	56	DAI_P12	100	$\overline{\text{TRST}}$	144
ADDR5	13	V_{DD_EXT}	57	DAI_P15	101	GND	145
BOOT_CFG1	14	NC	58	V_{DD_INT}	102	$\overline{\text{EMU}}$	146
GND	15	NC	59	DAI_P11	103	DATA0	147
ADDR6	16	NC	60	V_{DD_EXT}	104	DATA1	148
ADDR7	17	NC	61	V_{DD_INT}	105	DATA2	149
NC	18	V_{DD_INT}	62	BOOT_CFG2	106	DATA3	150
NC	19	NC	63	V_{DD_INT}	107	TDO	151
ADDR8	20	NC	64	AMI_ACK	108	DATA4	152
ADDR9	21	V_{DD_INT}	65	GND	109	V_{DD_EXT}	153
CLK_CFG0	22	NC	66	THD_M	110	DATA5	154
V_{DD_INT}	23	NC	67	THD_P	111	DATA6	155
CLKIN	24	V_{DD_INT}	68	V_{DD_THD}	112	V_{DD_INT}	156
XTAL	25	NC	69	V_{DD_INT}	113	DATA7	157
ADDR10	26	$\overline{\text{WDTRSTO}}$	70	V_{DD_INT}	114	TDI	158
NC	27	NC	71	$\overline{\text{MS1}}$	115	NC	159*
V_{DD_EXT}	28	V_{DD_EXT}	72	V_{DD_INT}	116	V_{DD_EXT}	160
V_{DD_INT}	29	DAI_P07	73	WDT_CLKO	117	DATA8	161
ADDR11	30	DAI_P13	74	WDT_CLKIN	118	DATA9	162
ADDR12	31	DAI_P19	75	V_{DD_EXT}	119	DATA10	163
ADDR17	32	DAI_P01	76	ADDR23	120	TCK	164
ADDR13	33	DAI_P02	77	ADDR22	121	DATA11	165
V_{DD_INT}	34	V_{DD_INT}	78	ADDR21	122	DATA12	166
ADDR18	35	NC	79	V_{DD_INT}	123	DATA14	167
$\overline{\text{RESETOUT}}/\overline{\text{RUNRSTIN}}$	36	NC	80	ADDR20	124	DATA13	168
V_{DD_INT}	37	NC	81	ADDR19	125	V_{DD_INT}	169
DPI_P01	38	NC	82	V_{DD_EXT}	126	DATA15	170
DPI_P02	39	NC	83	ADDR16	127	NC	171
DPI_P03	40	V_{DD_EXT}	84	ADDR15	128	NC	172
V_{DD_INT}	41	V_{DD_INT}	85	V_{DD_INT}	129	$\overline{\text{RESET}}$	173
DPI_P05	42	DAI_P06	86	ADDR14	130	TMS	174
DPI_P04	43	DAI_P05	87	$\overline{\text{AMI\_WR}}$	131	NC	175
DPI_P06	44	DAI_P09	88	$\overline{\text{AMI\_RD}}$	132	V_{DD_INT}	176
						GND	177**

*No external connection should be made to this pin. Use as NC only.

** Lead no. 177 (exposed pad) is the GND supply (see Figure 50 and Figure 51) for the processor; this pad must be **robustly** connected to GND.

Table 62. Automotive Models ADSP-21488, and ADSP-21489 176-Lead LQFP_EP Lead Assignment (Numerical by Lead Number)

Lead Name	Lead No.	Lead Name	Lead No.	Lead Name	Lead No.	Lead Name	Lead No.
SDDQM	1	V_{DD_EXT}	45	DAI_P10	89	V_{DD_INT}	133
$\overline{\text{MS0}}$	2	DPI_P08	46	V_{DD_INT}	90	FLAG0	134
SDCKE	3	DPI_P07	47	V_{DD_EXT}	91	FLAG1	135
V_{DD_INT}	4	V_{DD_INT}	48	DAI_P20	92	FLAG2	136
CLK_CFG1	5	DPI_P09	49	V_{DD_INT}	93	MLBCLK	137
ADDR0	6	DPI_P10	50	DAI_P08	94	FLAG3	138
BOOT_CFG0	7	DPI_P11	51	DAI_P14	95	MLBDAT	139
V_{DD_EXT}	8	DPI_P12	52	DAI_P04	96	MLBDO	140
ADDR1	9	DPI_P13	53	DAI_P18	97	V_{DD_EXT}	141
ADDR2	10	DPI_P14	54	DAI_P17	98	MLBSIG	142
ADDR3	11	DAI_P03	55	DAI_P16	99	V_{DD_INT}	143
ADDR4	12	NC	56	DAI_P12	100	$\overline{\text{TRST}}$	144
ADDR5	13	V_{DD_EXT}	57	DAI_P15	101	MLBSO	145
BOOT_CFG1	14	NC	58	V_{DD_INT}	102	$\overline{\text{EMU}}$	146
GND	15	NC	59	DAI_P11	103	DATA0	147
ADDR6	16	NC	60	V_{DD_EXT}	104	DATA1	148
ADDR7	17	NC	61	V_{DD_INT}	105	DATA2	149
NC	18	V_{DD_INT}	62	BOOT_CFG2	106	DATA3	150
NC	19	NC	63	V_{DD_INT}	107	TDO	151
ADDR8	20	NC	64	AMI_ACK	108	DATA4	152
ADDR9	21	V_{DD_INT}	65	GND	109	V_{DD_EXT}	153
CLK_CFG0	22	NC	66	THD_M	110	DATA5	154
V_{DD_INT}	23	NC	67	THD_P	111	DATA6	155
CLKIN	24	V_{DD_INT}	68	V_{DD_THD}	112	V_{DD_INT}	156
XTAL	25	NC	69	V_{DD_INT}	113	DATA7	157
ADDR10	26	$\overline{\text{WDTRSTO}}$	70	V_{DD_INT}	114	TDI	158
SDA10	27	NC	71	$\overline{\text{MS1}}$	115	SDCLK	159
V_{DD_EXT}	28	V_{DD_EXT}	72	V_{DD_INT}	116	V_{DD_EXT}	160
V_{DD_INT}	29	DAI_P07	73	WDT_CLKO	117	DATA8	161
ADDR11	30	DAI_P13	74	WDT_CLKIN	118	DATA9	162
ADDR12	31	DAI_P19	75	V_{DD_EXT}	119	DATA10	163
ADDR17	32	DAI_P01	76	ADDR23	120	TCK	164
ADDR13	33	DAI_P02	77	ADDR22	121	DATA11	165
V_{DD_INT}	34	V_{DD_INT}	78	ADDR21	122	DATA12	166
ADDR18	35	NC	79	V_{DD_INT}	123	DATA14	167
$\overline{\text{RESETOUT}}/\overline{\text{RUNRSTIN}}$	36	NC	80	ADDR20	124	DATA13	168
V_{DD_INT}	37	NC	81	ADDR19	125	V_{DD_INT}	169
DPI_P01	38	NC	82	V_{DD_EXT}	126	DATA15	170
DPI_P02	39	NC	83	ADDR16	127	$\overline{\text{SDWE}}$	171
DPI_P03	40	V_{DD_EXT}	84	ADDR15	128	$\overline{\text{SDRAS}}$	172
V_{DD_INT}	41	V_{DD_INT}	85	V_{DD_INT}	129	$\overline{\text{RESET}}$	173
DPI_P05	42	DAI_P06	86	ADDR14	130	TMS	174
DPI_P04	43	DAI_P05	87	$\overline{\text{AMI\_WR}}$	131	$\overline{\text{SDCAS}}$	175
DPI_P06	44	DAI_P09	88	$\overline{\text{AMI\_RD}}$	132	V_{DD_INT}	176
						GND	177*

* Lead no. 177 (exposed pad) is the GND supply (see Figure 50 and Figure 51) for the processor; this pad must be **robustly** connected to GND.

Figure 50 shows the top view of the 176-lead LQFP_EP lead configuration. Figure 51 shows the bottom view of the 176-lead LQFP_EP lead configuration.

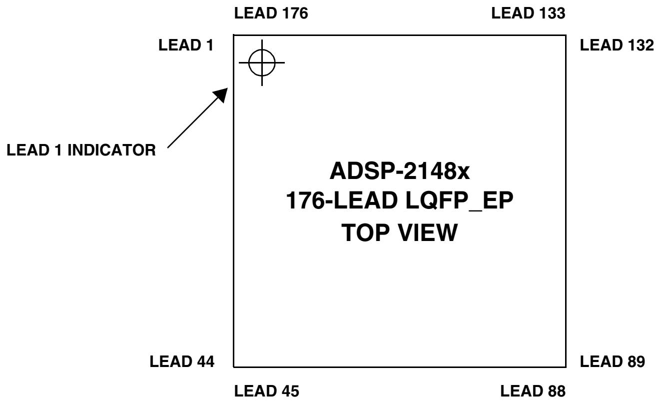

Figure 50. 176-Lead LQFP_EP Lead Configuration (Top View)

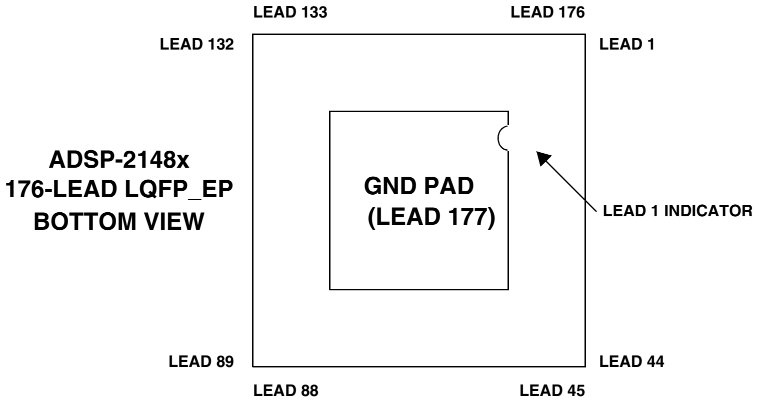

Figure 51. 176-Lead LQFP_EP Lead Configuration (Bottom View)

Model[1]	Notes	Temperature Range[2]	RAM	Processor Instruction Rate (Max)	Package Description	Package Option
ADSP-21487KSWZ-2B	3	0°C to +70°C	5 Mbit	300 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21487KSWZ-2BB	3	0°C to +70°C	5 Mbit	300 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21487KSWZ-3B	3	0°C to +70°C	5 Mbit	350 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21487KSWZ-3BB	3	0°C to +70°C	5 Mbit	350 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21487KSWZ-4B	3	0°C to +70°C	5 Mbit	400 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21487KSWZ-4BB	3	0°C to +70°C	5 Mbit	400 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21487KSWZ-5B	3, 4	0°C to +70°C	5 Mbit	450 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21487KSWZ-5BB	3, 4	0°C to +70°C	5 Mbit	450 MHz	176-Lead LQFP_EP	SW-176-2
ADSP21487KSWZ5BBRL	5	0°C to +70°C	5 Mbit	450 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21488BSWZ-3A		–40°C to +85°C	3 Mbit	350 MHz	100-Lead LQFP_EP	SW-100-2
ADSP-21488KSWZ-3A		0°C to +70°C	3 Mbit	350 MHz	100-Lead LQFP_EP	SW-100-2
ADSP-21488KSWZ-3A1	6	0°C to +70°C	3 Mbit	350 MHz	100-Lead LQFP_EP	SW-100-2
ADSP-21488KSWZ-3B		0°C to +70°C	3 Mbit	350 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21488BSWZ-3B		–40°C to +85°C	3 Mbit	350 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21488KSWZ-4A		0°C to +70°C	3 Mbit	400 MHz	100-Lead LQFP_EP	SW-100-2
ADSP-21488BSWZ-4A		–40°C to +85°C	3 Mbit	400 MHz	100-Lead LQFP_EP	SW-100-2
ADSP-21488KSWZ-4B		0°C to +70°C	3 Mbit	400 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21488BSWZ-4B		–40°C to +85°C	3 Mbit	400 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21488KSWZ-4B1	6	0°C to +70°C	3 Mbit	400 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21489KSWZ-3A		0°C to +70°C	5 Mbit	350 MHz	100-Lead LQFP_EP	SW-100-2
ADSP-21489BSWZ-3A		–40°C to +85°C	5 Mbit	350 MHz	100-Lead LQFP_EP	SW-100-2
ADSP-21489KSWZ-3B		0°C to +70°C	5 Mbit	350 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21489BSWZ-3B		–40°C to +85°C	5 Mbit	350 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21489KSWZ-4A		0°C to +70°C	5 Mbit	400 MHz	100-Lead LQFP_EP	SW-100-2
ADSP-21489BSWZ-4A		–40°C to +85°C	5 Mbit	400 MHz	100-Lead LQFP_EP	SW-100-2
ADSP-21489KSWZ-4B		0°C to +70°C	5 Mbit	400 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21489BSWZ-4B		–40°C to +85°C	5 Mbit	400 MHz	176-Lead LQFP_EP	SW-176-2
ADSP-21489KSWZ-5B	4	0°C to +70°C	5 Mbit	450 MHz	176-Lead LQFP_EP	SW-176-2

[1] Z = RoHS compliant part.

[2] Referenced temperature is ambient temperature. The ambient temperature is not a specification. Please see Operating Conditions on Page 18 for junction temperature (T_J) specification, which is the only temperature specification.

[3] The ADSP-21483, ADSP-21486, and ADSP-21487 models are available with factory programmed ROM including the latest multichannel audio decoding and post-processing algorithms from Dolby Labs and DTS. ROM contents may vary depending on chip version and silicon revision. Please visit www.analog.com for complete information.

[4] See Engineer-to-Engineer Note Static Voltage Scaling for ADSP-2148x SHARC Processors (EE-357) for operating ADSP-2148x processors at 450 MHz.

[5] RL = Tape and Reel.

[6] This product contains a –140 dB sample rate converter.